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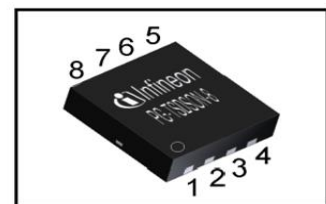
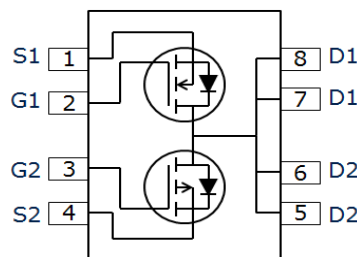


OptiMOS™2 + OptiMOS™-P 2 Small Signal Transistor
Features

- Complementary P + N channel
- Enhancement mode
- Super Logic level (2.5V rated)
- Common drain
- Avalanche rated
- 175 °C operating temperature
- Qualified according to AEC Q101
- 100% lead-free; RoHS compliant
- Halogen-free according to IEC61246-21

Product Summary

| | | P | N | |
|------------------|---------------------------|----------|----------|----|
| V_{DS} | | -20 | 20 | V |
| $R_{DS(on),max}$ | $V_{GS}=\pm 4.5\text{ V}$ | 150 | 55 | mΩ |
| | $V_{GS}=\pm 2.5\text{ V}$ | 310 | 95 | |
| I_D | | -3.2 | 5.1 | A |

PG-TSDSON-8


| Type | Package | Marking | Lead Free | Halogen Free | Packing |
|---------------|-------------|----------|-----------|--------------|---------|
| BSZ15DC02KD H | PG-TSDSON-8 | 15DC02KD | Yes | Yes | Non dry |

Maximum ratings, at $T_j=25\text{ °C}$, unless otherwise specified ¹⁾

| Parameter | Symbol | Conditions | Value | | Unit |
|-------------------------------------|----------------|--|-------------|----------|------|
| | | | P | N | |
| Continuous drain current | I_D | $T_A=25\text{ °C}$ | -3.2 | 5.1 | A |
| | | $T_A=100\text{ °C}$ | -2.2 | 3.6 | |
| Pulsed drain current | $I_{D,pulse}$ | $T_A=25\text{ °C}$ | -13 | 20 | |
| Avalanche energy, single pulse | E_{AS} | P: $I_D=-3.2\text{ A}$, N: $I_D=5.1\text{ A}$, $R_{GS}=25\text{ }\Omega$ | 11 | 11 | mJ |
| Gate source voltage | V_{GS} | | ± 12 | | V |
| Power dissipation | $P_{tot}^{2)}$ | $T_A=25\text{ °C}$ | 2.5 | | W |
| Operating and storage temperature | T_j, T_{stg} | | -55 ... 175 | | °C |
| ESD class | | JESD22-A114-HBM | 0 (<250V) | | |
| Soldering temperature | T_{solder} | | 260 | | °C |
| IEC climatic category; DIN IEC 68-1 | | | 55/175/56 | | |

¹⁾ Remark: only one of both transistors active

| Parameter | Symbol | Conditions | Values | | | Unit | |
|-------------------------------------|--------|------------|--|------|------|------|-----|
| | | | min. | typ. | max. | | |
| Thermal characteristics | | | | | | | |
| Thermal resistance, junction - case | P | R_{thJC} | | - | - | 8 | K/W |
| | N | | | | | | |
| Device on PCB | | R_{thJA} | 6 cm ² cooling area ²⁾ | - | - | 60 | K/W |

Electrical characteristics, at $T_j=25\text{ }^\circ\text{C}$, unless otherwise specified

Static characteristics

| | | | | | | | |
|----------------------------------|---|---------------|---|------|------|-----------|---------------|
| Drain-source breakdown voltage | P | $V_{(BR)DSS}$ | $V_{GS}=0\text{ V}, I_D=-250\text{ }\mu\text{A}$ | - | - | -20 | V |
| | N | | $V_{GS}=0\text{ V}, I_D=250\text{ }\mu\text{A}$ | 20 | - | - | |
| Gate threshold voltage | P | $V_{GS(th)}$ | $V_{DS}=V_{GS}, I_D=-110\text{ }\mu\text{A}$ | -1.4 | -1.0 | -0.7 | |
| | N | | $V_{DS}=V_{GS}, I_D=110\text{ }\mu\text{A}$ | 0.8 | 1.1 | 1.4 | |
| Zero gate voltage drain current | P | I_{DSS} | $V_{DS}=-20\text{ V}, V_{GS}=0\text{ V}, T_j=25\text{ }^\circ\text{C}$ | - | - | -0.1 | μA |
| | N | | $V_{DS}=20\text{ V}, V_{GS}=0\text{ V}, T_j=25\text{ }^\circ\text{C}$ | - | - | 0.1 | |
| | P | | $V_{DS}=-20\text{ V}, V_{GS}=0\text{ V}, T_j=175\text{ }^\circ\text{C}$ | - | - | -50 | |
| | N | | $V_{DS}=20\text{ V}, V_{GS}=0\text{ V}, T_j=175\text{ }^\circ\text{C}$ | - | - | 50 | |
| Gate-source leakage current | P | I_{GSS} | $V_{GS}=\pm 12\text{ V}, V_{DS}=0\text{ V}$ | - | - | ± 100 | nA |
| | N | | | | | | |
| Drain-source on-state resistance | P | $R_{DS(on)}$ | $V_{GS}=-2.5\text{ V}, I_D=2.1\text{ A}$ | - | 164 | 310 | m Ω |
| | N | | $V_{GS}=2.5\text{ V}, I_D=1.9\text{ A}$ | - | 63 | 95 | |
| | P | | $V_{GS}=-4.5\text{ V}, I_D=-3.2\text{ A}$ | - | 97 | 150 | |
| | N | | $V_{GS}=4.5\text{ V}, I_D=5.1\text{ A}$ | - | 41 | 55 | |
| Transconductance | P | g_{fs} | $ V_{DS} >2 I_D R_{DS(on)max}, I_D=-2.2\text{ A}$ | 3.4 | 6.9 | - | S |
| | N | | $ V_{DS} >2 I_D R_{DS(on)max}, I_D=3.6\text{ A}$ | 5.5 | 11 | - | |

²⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.

| Parameter | Symbol | Conditions | Values | | | Unit |
|-----------|--------|------------|--------|------|------|------|
| | | | min. | typ. | max. | |

Dynamic characteristics

| | | | | | | | | | | |
|------------------------------|---|--------------|--|--|--|---|-----|------|---|----|
| Input capacitance | P | C_{iss} | $V_{GS}=0\text{ V}$, P: $V_{DS}=-10\text{ V}$, N: $V_{DS}=10\text{ V}$, $f=1\text{ MHz}$ | - | 270 | 360 | pF | | | |
| | N | | | - | 315 | 419 | | | | |
| Output capacitance | P | C_{oss} | | $V_{GS}=0\text{ V}$, P: $V_{DS}=-10\text{ V}$, N: $V_{DS}=10\text{ V}$, $f=1\text{ MHz}$ | - | 110 | 150 | | | |
| | N | | | | - | 114 | 152 | | | |
| Reverse transfer capacitance | P | C_{rss} | | | $V_{GS}=0\text{ V}$, P: $V_{DS}=-10\text{ V}$, N: $V_{DS}=10\text{ V}$, $f=1\text{ MHz}$ | - | 94 | 140 | | |
| | N | | | | | - | 16 | 24 | | |
| Turn-on delay time | P | $t_{d(on)}$ | | | | P: $V_{DD}=-10\text{ V}$, $V_{GS}=-4.5\text{ V}$, $R_G=6\ \Omega$, $I_D=-3.2\text{ A}$ | - | 7.4 | - | ns |
| | N | | | | | | - | 4.9 | - | |
| Rise time | P | t_r | P: $V_{DD}=-10\text{ V}$, $V_{GS}=-4.5\text{ V}$, $R_G=6\ \Omega$, $I_D=-3.2\text{ A}$ | | | | - | 3.7 | - | |
| | N | | | | | | - | 2.0 | - | |
| Turn-off delay time | P | $t_{d(off)}$ | | N: $V_{DD}=10\text{ V}$, $V_{GS}=4.5\text{ V}$, $R_G=6\ \Omega$, $I_D=5.1\text{ A}$ | | | - | 11.3 | - | |
| | N | | | | | | - | 12.2 | - | |
| Fall time | P | t_f | | | N: $V_{DD}=10\text{ V}$, $V_{GS}=4.5\text{ V}$, $R_G=6\ \Omega$, $I_D=5.1\text{ A}$ | | - | 4.7 | - | |
| | N | | | | | | - | 1.4 | - | |

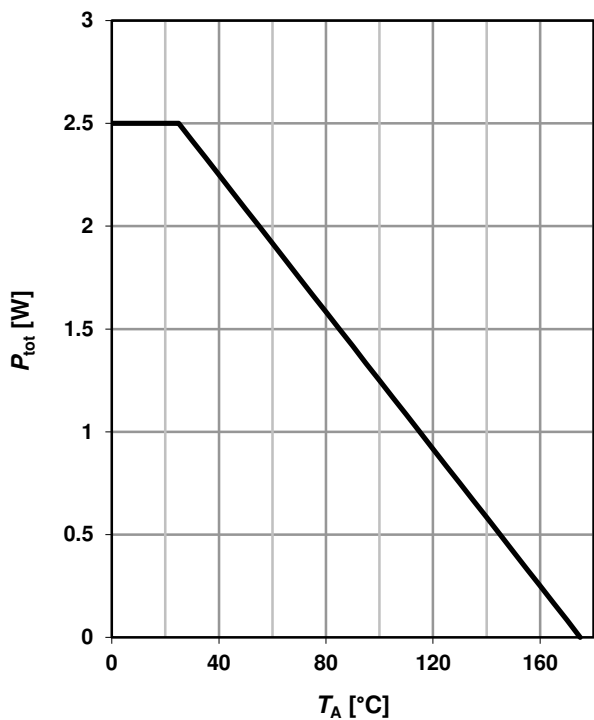
Gate Charge Characteristics

| | | | | | | | |
|-----------------------|---|---------------|--|---|-------|------|----|
| Gate to source charge | P | Q_{gs} | $V_{DD}=-10\text{ V}$, $I_D=-3.2\text{ A}$, $V_{GS}=0\text{ to }-4.5\text{ V}$ | - | -0.59 | -0.8 | nC |
| Gate to drain charge | | Q_{gd} | | - | -1.4 | -1.8 | |
| Switching charge | | Q_g | | - | -3.0 | -4.5 | |
| Gate plateau voltage | | $V_{plateau}$ | | - | -2.2 | - | |
| Gate to source charge | N | Q_{gs} | $V_{DD}=10\text{ V}$, $I_D=5.1\text{ A}$, $V_{GS}=0\text{ to }4.5\text{ V}$ | - | 0.7 | 1.0 | |
| Gate to drain charge | | Q_{gd} | | - | 0.4 | - | |
| Switching charge | | Q_g | | - | 2.1 | 2.8 | |
| Gate plateau voltage | | $V_{plateau}$ | | - | 2.3 | - | |

| Parameter | Symbol | Conditions | Values | | | Unit | | |
|----------------------------------|--------|---------------|---|------|-------|------|----|----|
| | | | min. | typ. | max. | | | |
| Reverse Diode | | | | | | | | |
| Diode continuous forward current | P | I_S | $T_C=25\text{ °C}$ | - | - | -2.1 | A | |
| | N | | | | | 2.3 | | |
| Diode pulse current | P | $I_{S,pulse}$ | | - | - | -13 | | |
| | N | | | | | 20 | | |
| Diode forward voltage | P | V_{SD} | $V_{GS}=0\text{ V}, I_F=3.2\text{ A},$ $T_j=25\text{ °C}$ | - | -0.98 | -1.2 | V | |
| | N | | $V_{GS}=0\text{ V}, I_F=5.1\text{ A},$ $T_j=25\text{ °C}$ | - | 0.9 | 1.2 | | |
| Reverse recovery time | P | t_{rr} | $V_R=\pm 10\text{ V}, I_F=I_S,$ $di_F/dt=100\text{ A}/\mu\text{s}$ | | 12.2 | | ns | |
| | N | | | - | 10.9 | - | | |
| Reverse recovery charge | P | Q_{rr} | | | | 4.6 | | nC |
| | N | | | - | 3.4 | - | | |

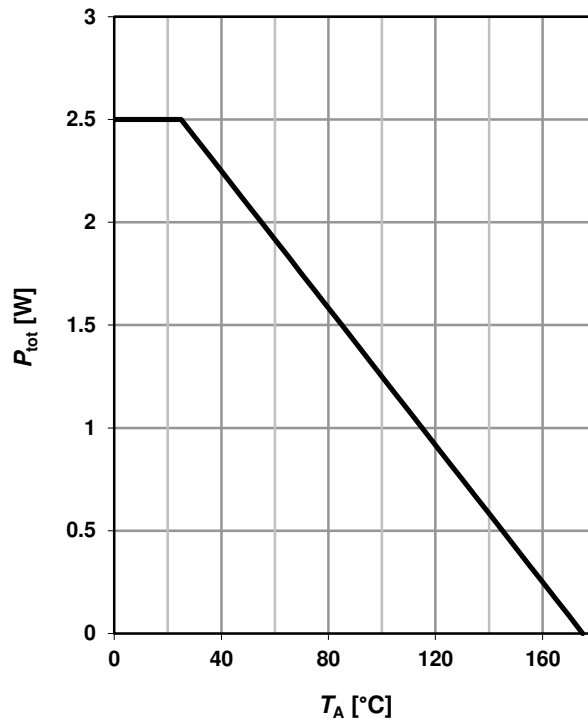
1 Power dissipation (P)

$P_{tot}=f(T_A)$



2 Power dissipation (N)

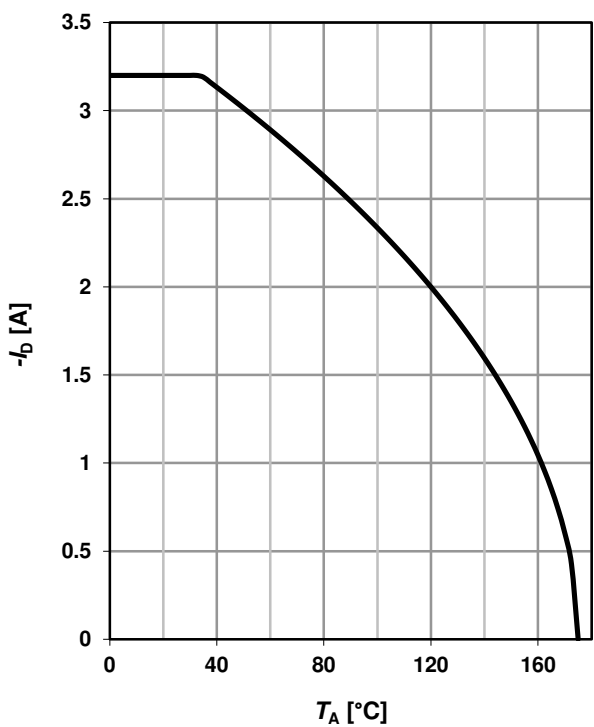
$P_{tot}=f(T_A)$



3 Drain current (P)

$I_D=f(T_A)$

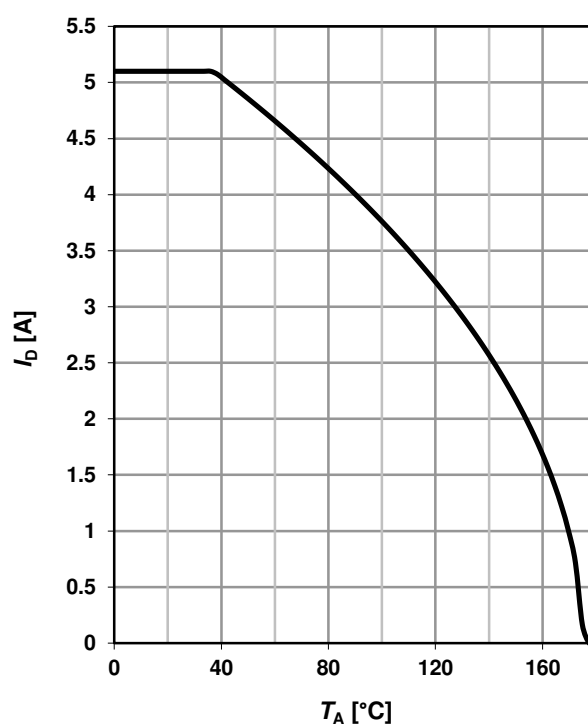
parameter: $V_{GS} \leq 4.5$ V



4 Drain current (N)

$I_D=f(T_A)$

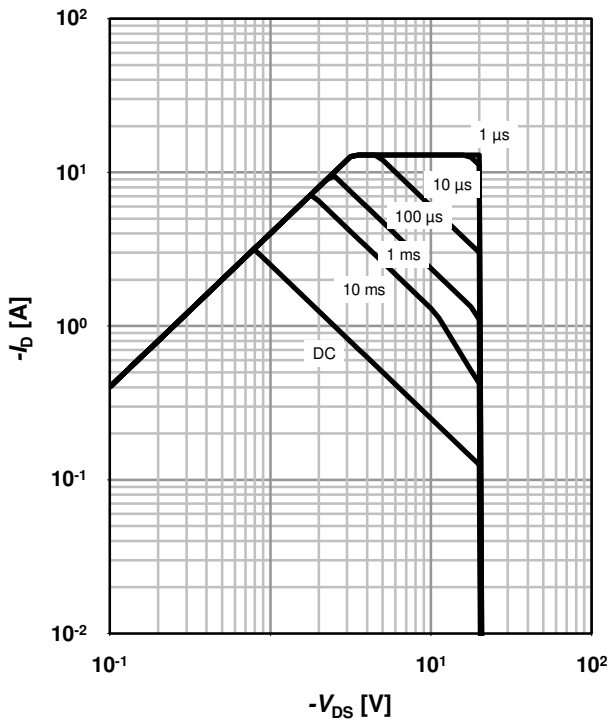
parameter: $V_{GS} \geq 4.5$ V



5 Safe operating area (P)

$I_D=f(V_{DS}); T_A=25\text{ }^\circ\text{C}; D=0$

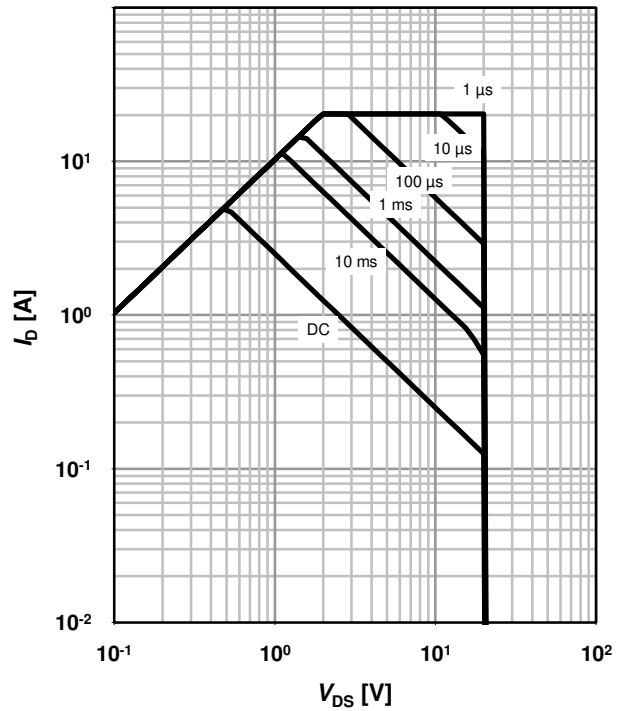
parameter: t_p



6 Safe operating area (N)

$I_D=f(V_{DS}); T_A=25\text{ }^\circ\text{C}; D=0$

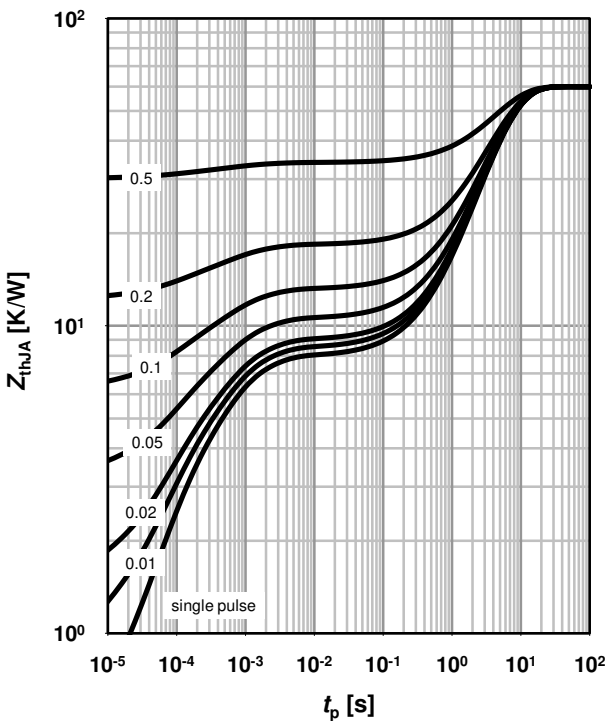
parameter: t_p



7 Max. transient thermal impedance (P)

$Z_{thJA}=f(t_p)$

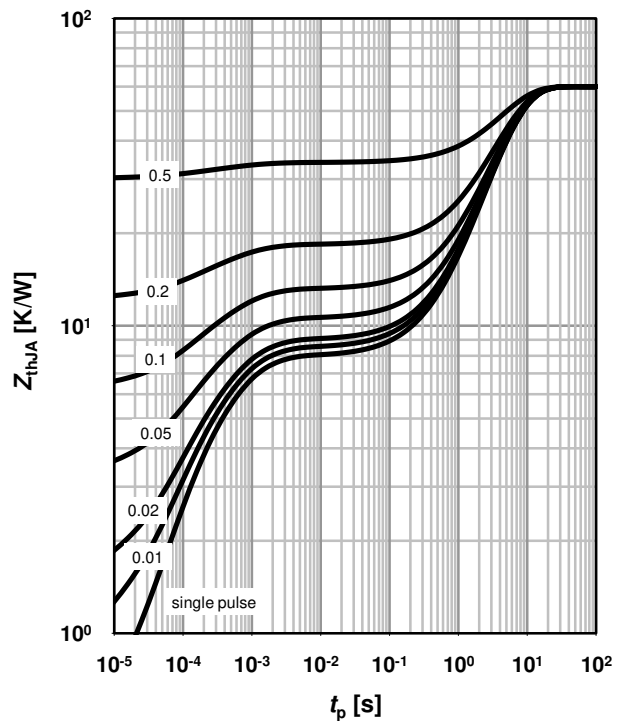
parameter: $D=t_p/T$



8 Max. transient thermal impedance (N)

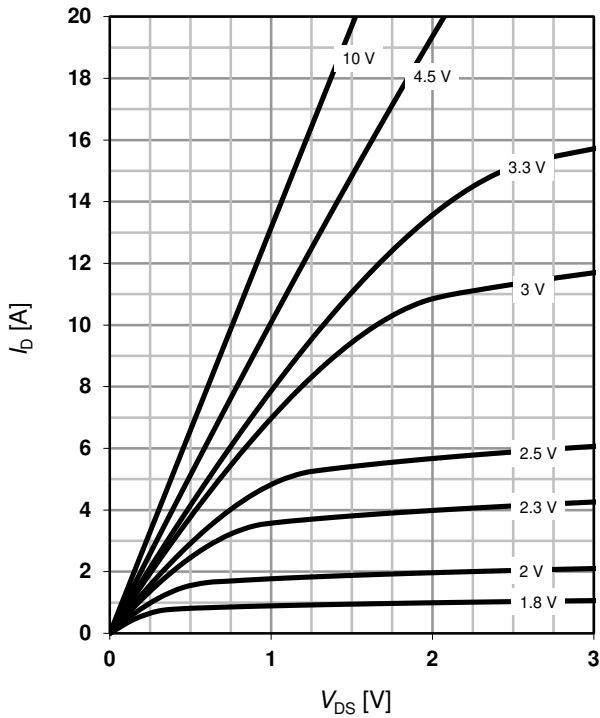
$Z_{thJA}=f(t_p)$

parameter: $D=t_p/T$

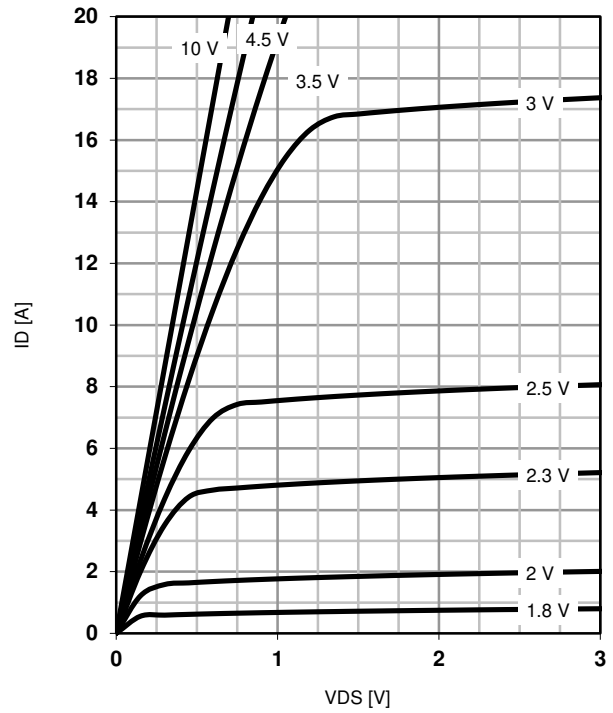


9 Typ. output characteristics (P)

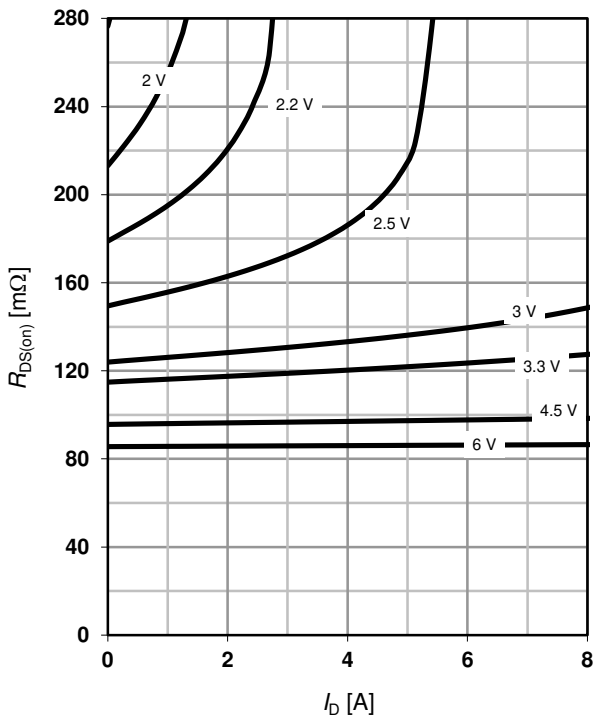
$$I_D = f(V_{DS}); T_j = 25\text{ °C}$$

 parameter: V_{GS}

10 Typ. output characteristics (N)

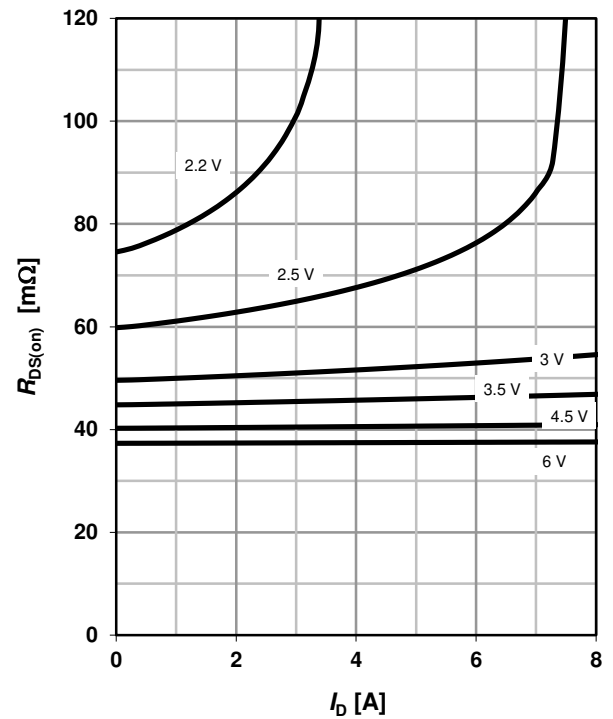
$$I_D = f(V_{DS}); T_j = 25\text{ °C}$$

 parameter: V_{GS}

11 Typ. drain-source on resistance (P)

$$R_{DS(on)} = f(I_D); T_j = 25\text{ °C}$$

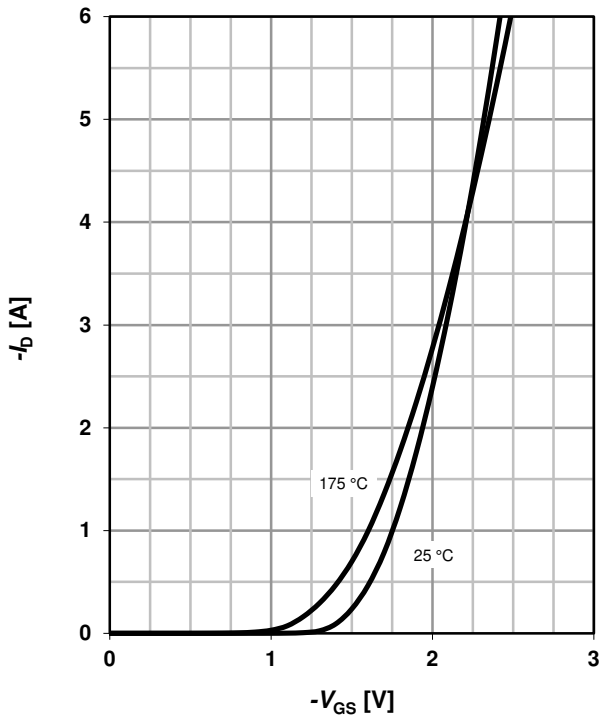
 parameter: V_{GS}

12 Typ. drain-source on resistance (N)

$$R_{DS(on)} = f(I_D); T_j = 25\text{ °C}$$

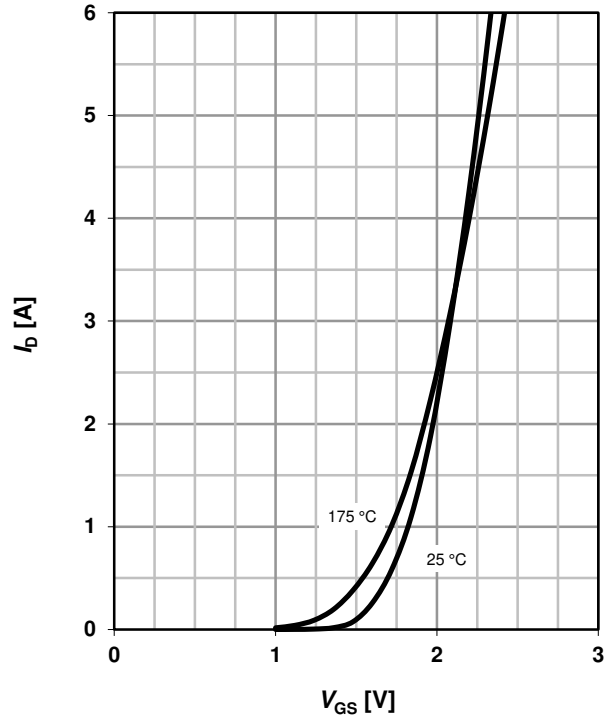
 parameter: V_{GS}


13 Typ. transfer characteristics (P)

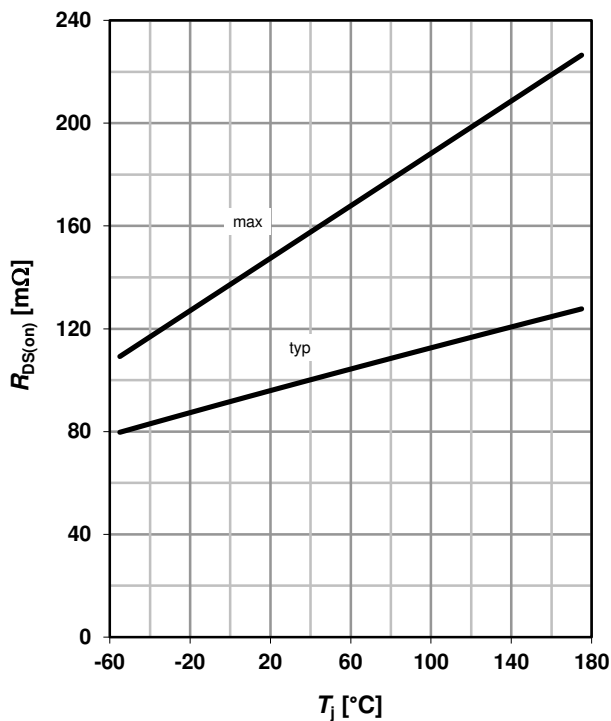
$$I_D = f(V_{GS}); |V_{DS}| > 2 |I_D| R_{DS(on)max}$$

 parameter: T_j

14 Typ. transfer characteristics (N)

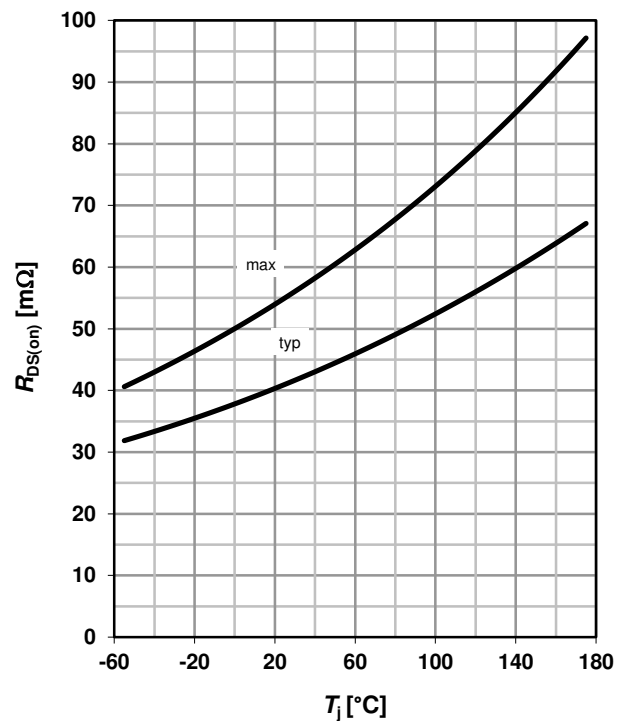
$$I_D = f(V_{GS}); |V_{DS}| > 2 |I_D| R_{DS(on)max}$$

 parameter: T_j

15 Drain-source on-state resistance (P)

$$R_{DS(on)} = f(T_j); I_D = -3.2 \text{ A}; V_{GS} = -4.5 \text{ V}$$

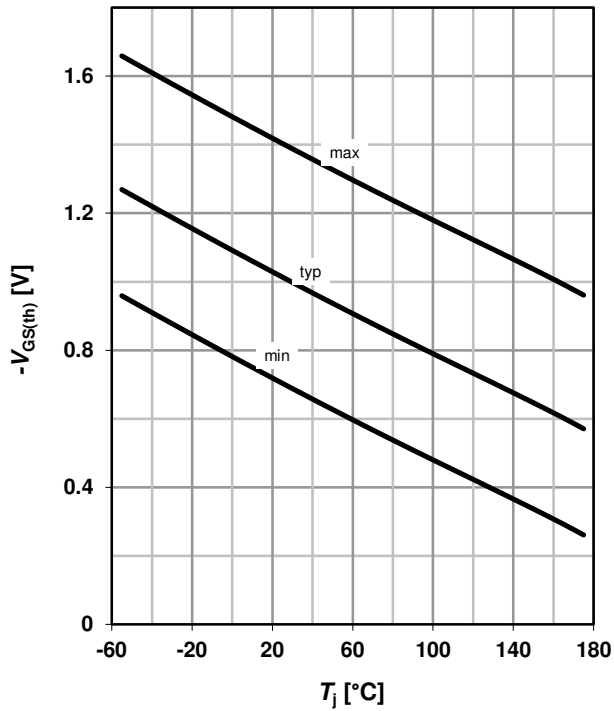

16 Drain-source on-state resistance (N)

$$R_{DS(on)} = f(T_j); I_D = 5.1 \text{ A}; V_{GS} = 4.5 \text{ V}$$

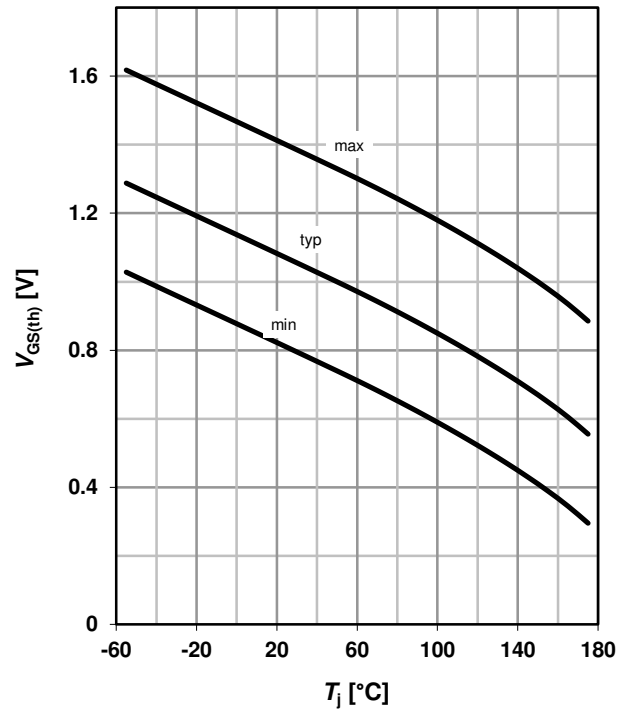


17 Typ. gate threshold voltage (P)

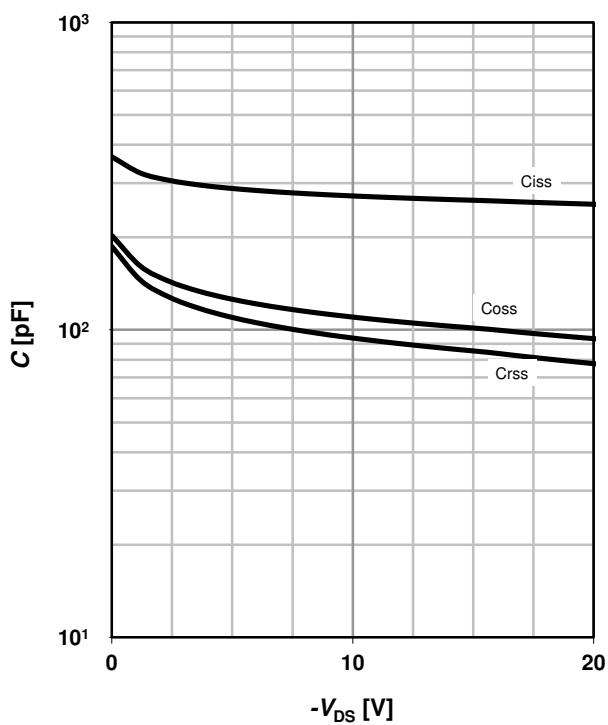
$$V_{GS(th)}=f(T_j); V_{GS}=V_{DS}; I_D=-110 \mu A$$


18 Typ. gate threshold voltage (N)

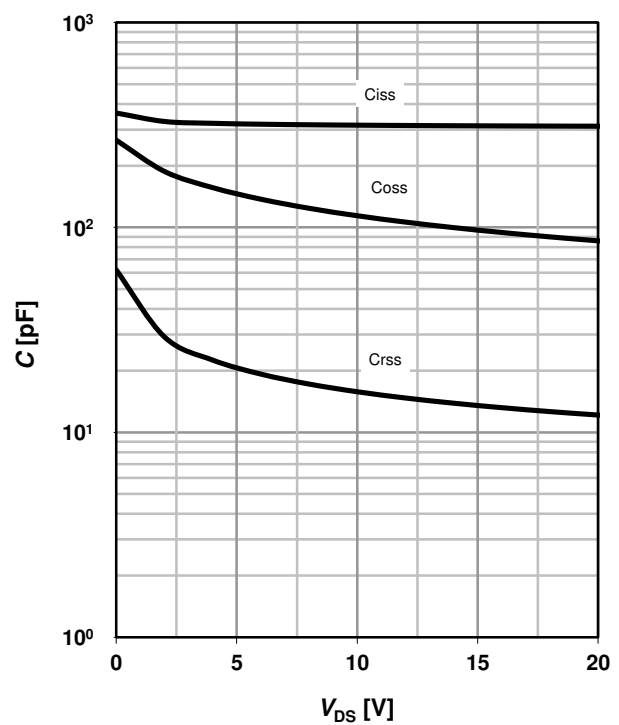
$$V_{GS(th)}=f(T_j); V_{GS}=V_{DS}; I_D=110 \mu A$$


19 Typ. capacitances (P)

$$C=f(V_{DS}); V_{GS}=0 V; f=1 MHz$$


20 Typ. capacitances (N)

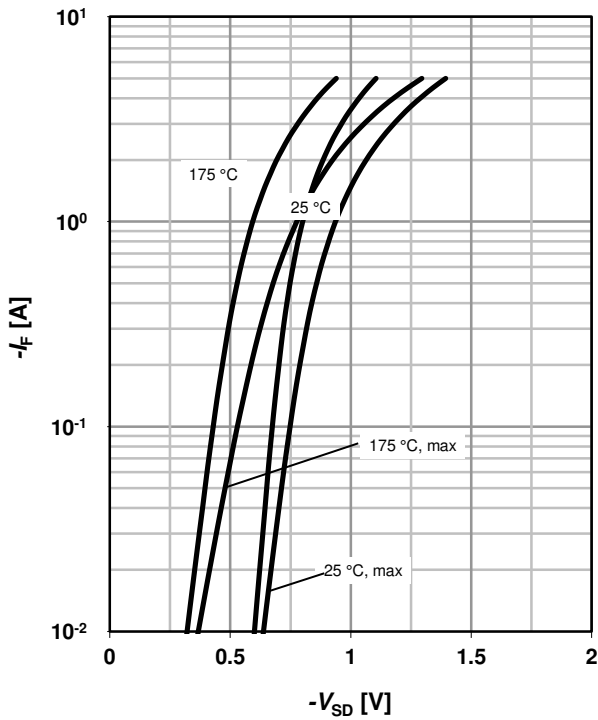
$$C=f(V_{DS}); V_{GS}=0 V; f=1 MHz$$



21 Forward characteristics of reverse diode (P)

$I_F=f(V_{SD})$

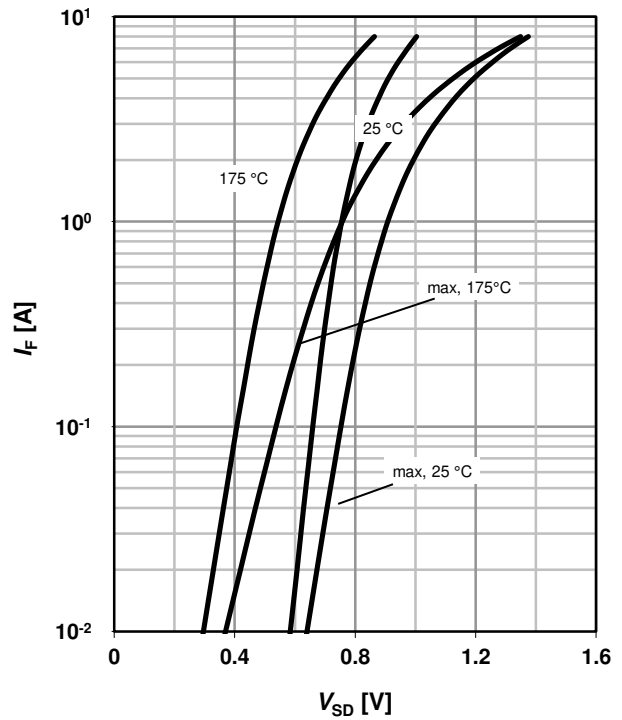
parameter: T_j



22 Forward characteristics of reverse diode (N)

$I_F=f(V_{SD})$

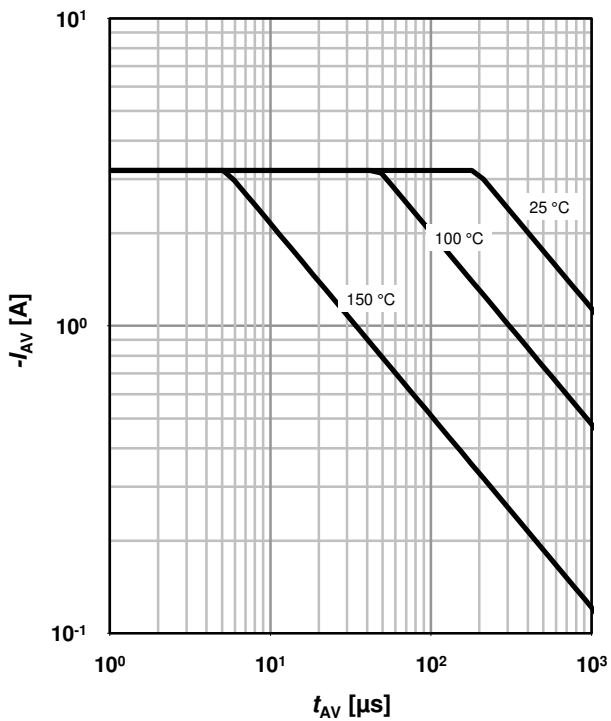
parameter: T_j



23 Avalanche characteristics (P)

$I_{AS}=f(t_{AV}); R_{GS}=25 \Omega$

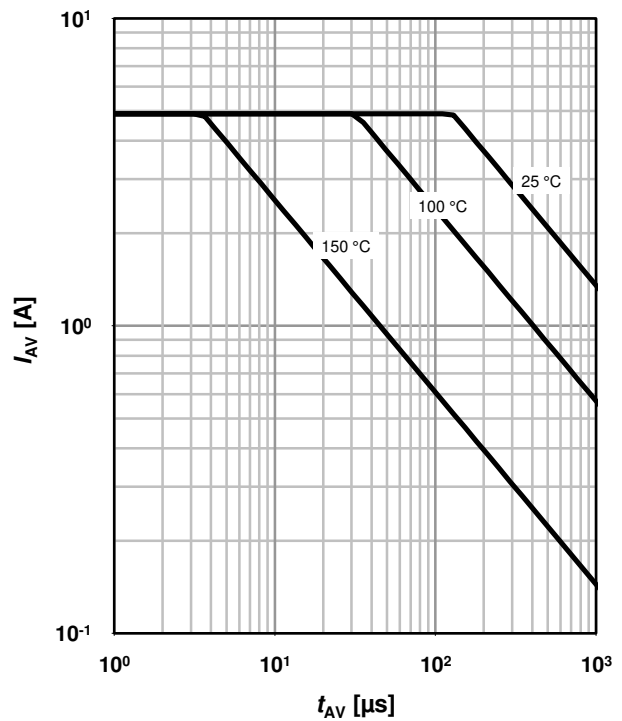
parameter: $T_{j(start)}$



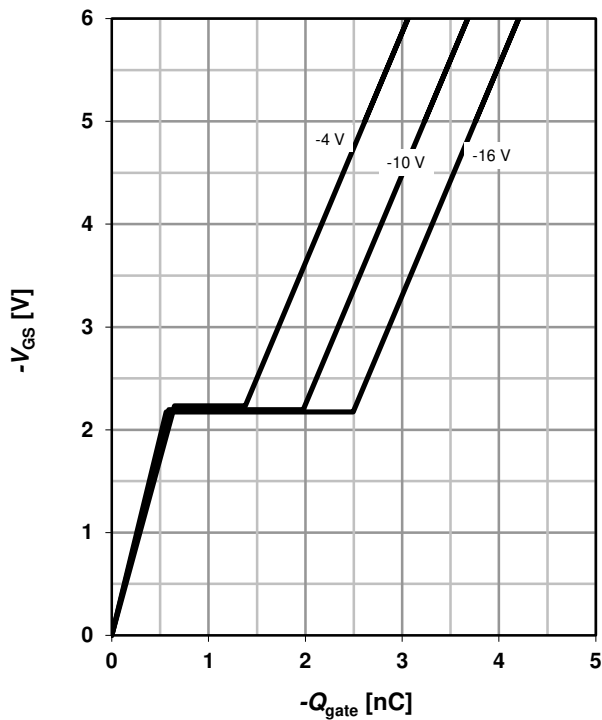
24 Avalanche characteristics (N)

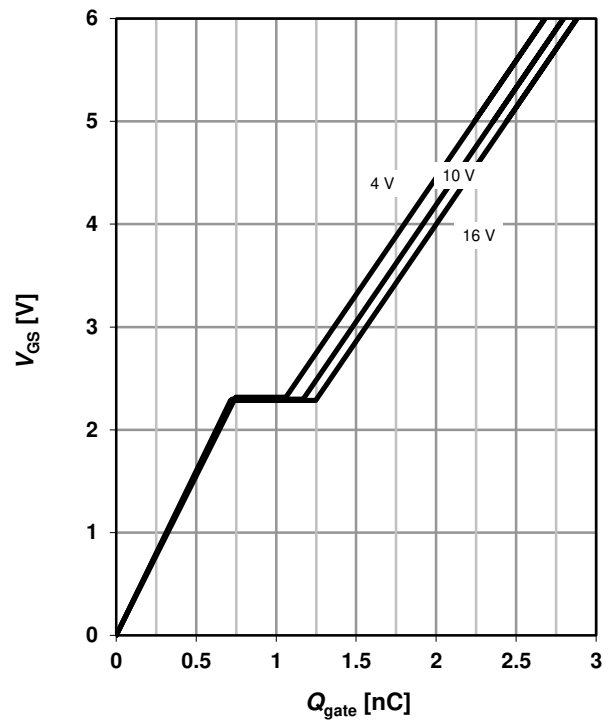
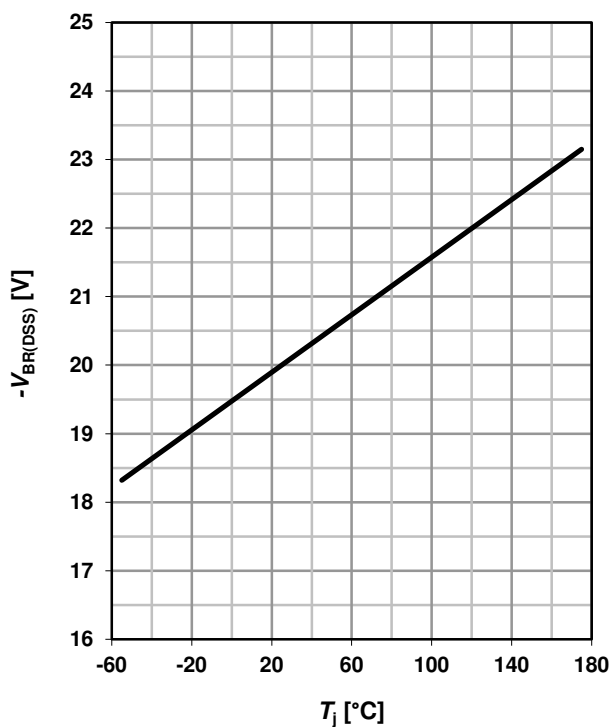
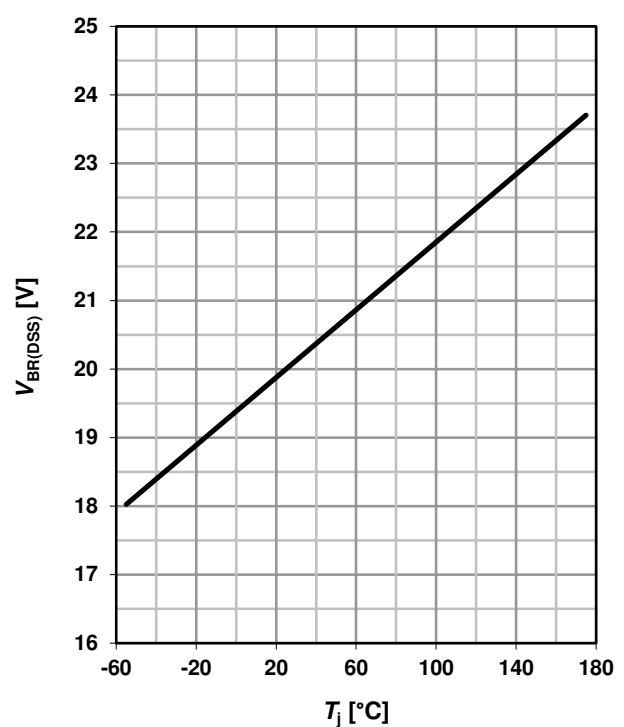
$I_{AS}=f(t_{AV}); R_{GS}=25 \Omega$

parameter: $T_{j(start)}$



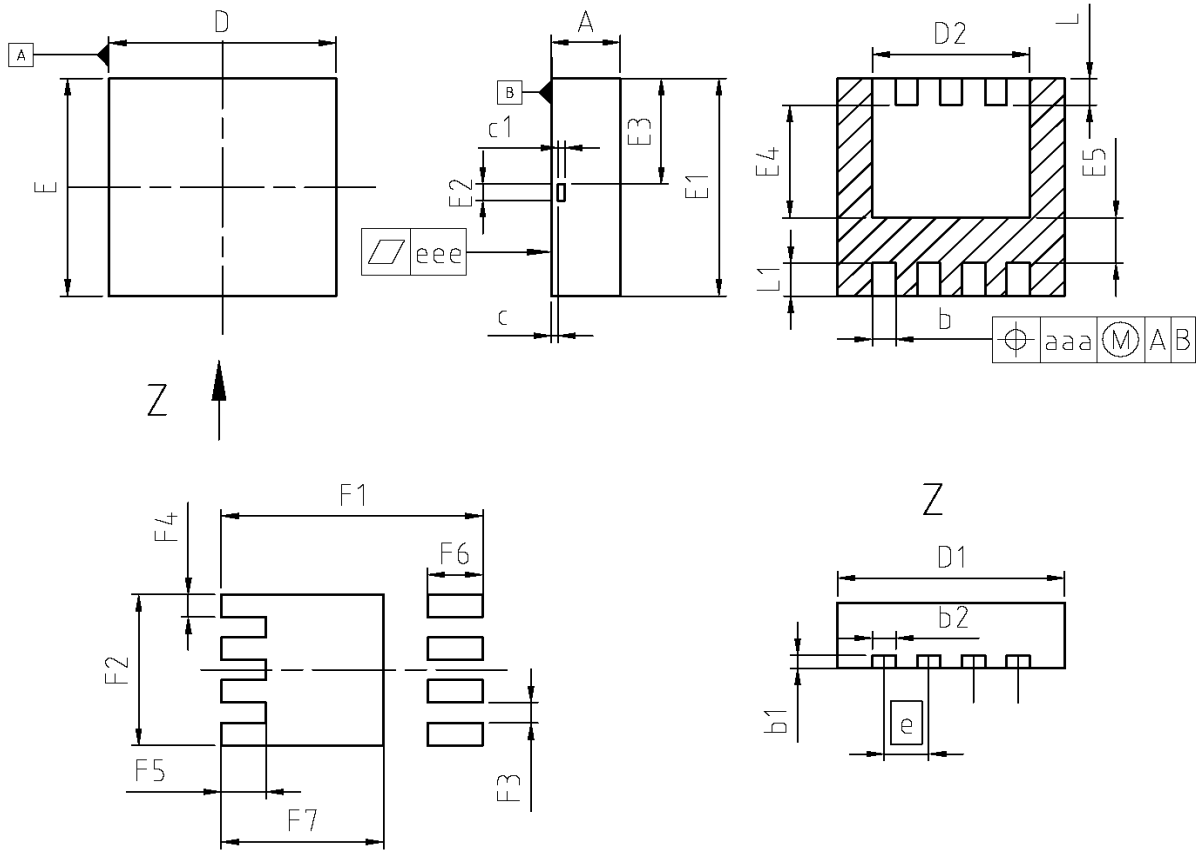
25 Typ. gate charge (P)
 $V_{GS}=f(Q_{gate}); I_D=-3.2A$ pulsed

 parameter: V_{DD}

26 Typ. gate charge (N)
 $V_{GS}=f(Q_{gate}); I_D=5.1A$ pulsed

 parameter: V_{DD}

27 Drain-source breakdown voltage (P)
 $V_{BR(DSS)}=f(T_j); I_D=-250 \mu A$

28 Drain-source breakdown voltage (N)
 $V_{BR(DSS)}=f(T_j); I_D=250 \mu A$


Package Outline

PG-TSDSON-8



| DIM | MILLIMETERS | | INCHES | |
|------|-------------|------|--------|-------|
| | MIN | MAX | MIN | MAX |
| A | 0.95 | 1.00 | 0.037 | 0.039 |
| b | 0.25 | 0.35 | 0.010 | 0.014 |
| b1 | 0.10 | 0.30 | 0.004 | 0.012 |
| b2 | 0.20 | 0.40 | 0.008 | 0.016 |
| c | 0.00 | 0.20 | 0.000 | 0.008 |
| D=D1 | 3.20 | 3.40 | 0.126 | 0.134 |
| D2 | 2.15 | 2.35 | 0.085 | 0.093 |
| E=E1 | 3.20 | 3.40 | 0.126 | 0.134 |
| E2 | 0.10 | 0.30 | 0.004 | 0.012 |
| E3 | 1.35 | 1.55 | 0.053 | 0.061 |
| E4 | 1.60 | 1.80 | 0.063 | 0.071 |
| E5 | 0.66 | 0.86 | 0.026 | 0.034 |
| e | 0.60 | 0.70 | 0.024 | 0.028 |
| N | 8 | | 8 | |
| L | 0.31 | 0.51 | 0.012 | 0.020 |
| L1 | 0.33 | 0.53 | 0.013 | 0.021 |
| aaa | 0.25 | | 0.010 | |
| eee | 0.05 | | 0.002 | |
| F1 | 3.70 | 3.90 | 0.146 | 0.154 |
| F2 | 2.19 | 2.39 | 0.086 | 0.094 |
| F3 | 0.21 | 0.41 | 0.008 | 0.016 |
| F4 | 0.24 | 0.44 | 0.009 | 0.017 |
| F5 | 0.55 | 0.75 | 0.022 | 0.030 |
| F6 | 0.70 | 0.90 | 0.028 | 0.035 |
| F7 | 2.26 | 2.46 | 0.089 | 0.097 |

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SCALE

EUROPEAN PROJECTION

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